MN101C66 Series

Туре	MN101C66D	MN101C66G	MN101CF66G	MN101CP66D		
Internal ROM type	Mask ROM FLASH E			EPROM		
ROM (byte)	64K	12	64K			
RAM (byte)	2K	4	K 2K			
Package (Lead-free)	LQFP080-P-1414A, QFP084-P-1818E	LQFP080-P-1414A (ES (Engineering Sample) available), QFP084-P-1818E	LQFP080-P-1414A	, QFP084-P-1818E		
Minimum Instruction Execution Time	0.1 μs (at 4.5 V to 5.5 V, 20 MHz) 0.25 μs (at 2.7 V to 5.5 V, 8 MHz) 62.5 μs (at 2.0 V to 5.5 V, 32 kHz)* *: The lower limit for operation guarantee for flash memory built-in type is 2.5 V. The lower limit for operation guarantee for EPROM built-in type is 2.3 V.					

Interrupts

RESET. Watchdog. External 0 to 2. External 3 (LQFP080-P-1414A: Not mounted). External 4 (key interrupt dedicated). Timer 0 to 3. Timer 6. Timer 7 (2 systems). Timer 8 (2 systems). Time base. Serial 0 (2 systems). Serial 2. A/D conversion finish

■ Timer Counter

	8-bit	timer	X	5
--	-------	-------	---	---

Timer 0Square-wave/8-bit PWM output. Event count. Remote control carrier output. Simple pulse width measurement.
Square-wave/PWM output to large current terminal P50 possible
Timer 1Square-wave output. Event count. Synchronous output event
Timer 2Square-wave output. Added pulse (2-bit) type PWM output. Event count. Synchronous output event. Simple pulse
width measurement. Square-wave/PWM output to large current terminal P52 possible
Timer 3Square-wave output. Event count. Remote control carrier output. Serial 0 baud rate timer
Timer 68-bit freerun timer
Timer 0, 1 can be cascade-connected

Timer 2, 3 can be cascade-connected 16-bit timer \times 2

Timer 7Square-wave output. Square-wave/16-bit PWM output (cycle/duty continuous variable). Event count. Synchronous output event. Pulse width measurement. Input capture. Square-wave/PWM output to large current terminal P51 possible

Timer 8Square-wave/16-bit PWM output (duty continuous variable). Event count. Pulse width measurement. Input capture. Square-wave/PWM output to large current terminal P53 possible

Timer 7, 8 can be cascade-connected: Square-wave output, PWM, input capture, pulse width measurement is possible as a 32-bit

Time base timer: One-minute count setting

Watchdog timer × 1

■ Serial interface

Synchronous type/UART (full-duplex) × 1: Serial 0

Synchronous type \times 1: Serial 2

■ I/O Pins

Input

 $61: Common use. Specified pull-up resistor available. Input/output selectable (bit unit) <math display="inline">(60): \ LQFP080\text{-P-}1414A$ I/O

4: Common use. Specified pull-up resistor available

(3): LQFP080-P-1414A

■ A/D converter

10-bit × 8 channels (with S/H)

■ Display control function

LCD: 32 segments × 4 commons (Static, 1/2, 1/3, or 1/4 duty)

LCD power supply separated from VDD (usable if VLCD ≤ VDD)

LCD power shunt resistance contained

■ Special Ports

Buzzer output. Remote control carrier output. High-current drive port

Panasonic MAD00017KEM

MN101C66D, MN101C66G, MN101CF66G, MN101CP66D

■ Electrical Charactreistics (Supply current)

Parameter	Symbol	Condition		Limit		
	Symbol			typ	max	Unit
Operating supply current	IDD1	fosc = 20 MHz. VDD = 5 V		25	60	mA
	IDD2	fosc = 8 MHz. VDD = 5 V		10	25	mA
	IDD3	fx = 32 kHz. VDD = 3 V		30	100	μA
Supply current at HALT	IDD4	fx = 32 kHz. VDD = 3 V. Ta = 25 °C		4	8	μA
	IDD5	$fx = 32 \text{ kHz. VDD} = 3 \text{ V. Ta} = -40 ^{\circ}\text{C to} +85 ^{\circ}\text{C}$			30	μА
Supply current at STOP	IDD6	VDD = 5 V. Ta = 25 °C			2	μA
	IDD7	$VDD = 5 \text{ V. } \text{Ta} = -40 ^{\circ}\text{C} \text{ to } +85 ^{\circ}\text{C}$			50	μA

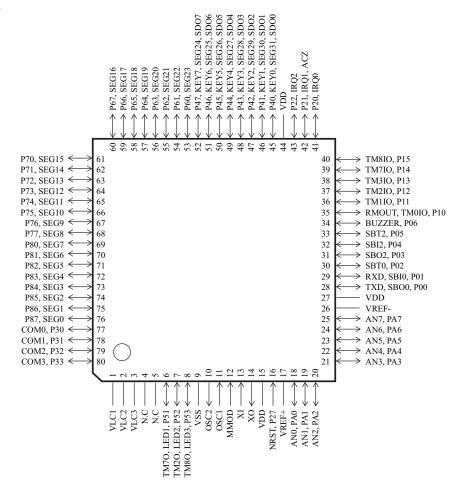
■ Development tools

In-circuit Emulator

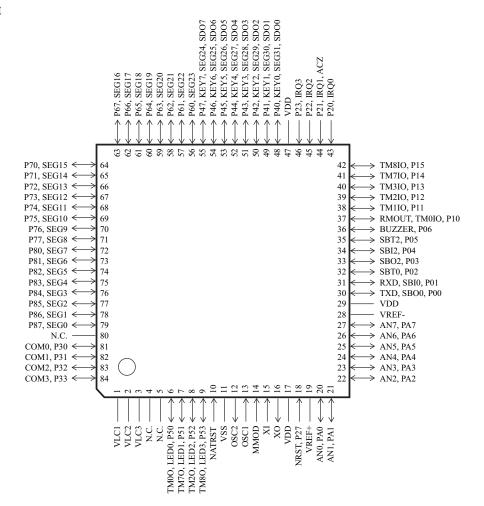
PX-ICE101C/D + PX-PRB101C66-QFP084-P-1818E-M PX-ICE101C/D + PX-PRB101C66-LQFP080-P-1414A-M

■ Pin Assignment

LQFP080-P-1414A



MAD00017KEM Panasonic



Panasonic MAD00017KEM

Request for your special attention and precautions in using the technical information and semiconductors described in this book

- (1) If any of the products or technical information described in this book is to be exported or provided to non-residents, the laws and regulations of the exporting country, especially, those with regard to security export control, must be observed.
- (2) The technical information described in this book is intended only to show the main characteristics and application circuit examples of the products, and no license is granted under any intellectual property right or other right owned by our company or any other company. Therefore, no responsibility is assumed by our company as to the infringement upon any such right owned by any other company which may arise as a result of the use of technical information described in this book.
- (3) The products described in this book are intended to be used for standard applications or general electronic equipment (such as office equipment, communications equipment, measuring instruments and household appliances).
 Consult our sales staff in advance for information on the following applications:
 - Special applications (such as for airplanes, aerospace, automobiles, traffic control equipment, combustion equipment, life support systems and safety devices) in which exceptional quality and reliability are required, or if the failure or malfunction of the products may directly jeopardize life or harm the human body.
 - · Any applications other than the standard applications intended.
- (4) The products and product specifications described in this book are subject to change without notice for modification and/or improvement. At the final stage of your design, purchasing, or use of the products, therefore, ask for the most up-to-date Product Standards in advance to make sure that the latest specifications satisfy your requirements.
- (5) When designing your equipment, comply with the range of absolute maximum rating and the guaranteed operating conditions (operating power supply voltage and operating environment etc.). Especially, please be careful not to exceed the range of absolute maximum rating on the transient state, such as power-on, power-off and mode-switching. Otherwise, we will not be liable for any defect which may arise later in your equipment.

 Even when the products are used within the guaranteed values, take into the consideration of incidence of break down and failure.
 - Even when the products are used within the guaranteed values, take into the consideration of incidence of break down and failure mode, possible to occur to semiconductor products. Measures on the systems such as redundant design, arresting the spread of fire or preventing glitch are recommended in order to prevent physical injury, fire, social damages, for example, by using the products.
- (6) Comply with the instructions for use in order to prevent breakdown and characteristics change due to external factors (ESD, EOS, thermal stress and mechanical stress) at the time of handling, mounting or at customer's process. When using products for which damp-proof packing is required, satisfy the conditions, such as shelf life and the elapsed time since first opening the packages.
- (7) This book may be not reprinted or reproduced whether wholly or partially, without the prior written permission of Matsushita Electric Industrial Co., Ltd.